



Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10530429	TSUBOUCHI ET AL.
	Examiner Nolan, Ph.D., Jason M	Art Unit 1626

Notes	Date	Examiner
STN Structure Search (Registry/Caplus) - printout attached	11/01/2006	Jason M. Nolan, Ph.D.
Inventor Search - reviewed for double patenting	11/03/2006	Nolan
Abstract and Oath Reviewed	11/03/2006	Nolan
PCT and Priority Documents reviewed	11/03/2006	Nolan
East Class/Subclass searched, printout attached	11/6/06	Nolan
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	<p>Examiner</p> <p>Nolan, Ph.D., Jason M</p>	<p>Art Unit</p> <p>1626</p>

Class	SubClass	Date	Examiner
548	218	11/6/06	Jason Nolan

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